

Type 3521 Series

Key Features

2 Watts at 70°C

Small size to power ratio

Supplied on tape

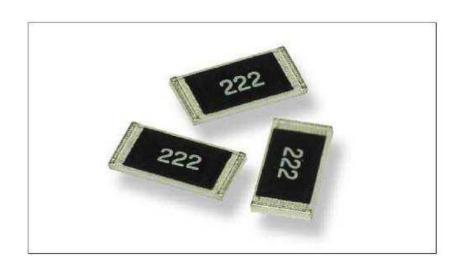
Value marked on resistor

500 volt maximum overload

250 volt maximum working voltage

Terminal finish matte Sn over Ni

AEC-Q200 Qualified

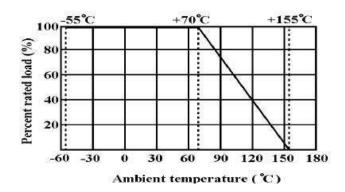


TE Connectivity is pleased to announce that our 3521 series high power Thick Film Chip Resistor is now AEC-Q200 Qualified. This low cost device, suitable for auto placement in volume, and for most applications, including high frequency operations, owing to the short lead structure, is attractively priced and available on 7" reels of 4000 pieces.

Characteristics – Electrical

Power Rating	2W
Resistance Range	1Ω ~ 10ΜΩ
Tolerance	±1% ±5%
Max. Working Voltage	250V
Max. Overload Voltage	500V
Dielectric Withstanding Voltage	500V
Temperature Range	-55°C ~ +155°C
Ambient Temperature	70°C

Resistors shall have a power rating based on continuous load operation at an ambient temperature of 70 $^{\circ}$ C . For temperature in excess of 70 $^{\circ}$ C , The load shall be derated as shown below:





Voltage Rating:

Resistors shall have a rated direct-current (DC) continuous working voltage or an approximate sine-wave root-mean-square (RMS) alternating-current (AC) continuous working voltage at commercial line frequency and waveform corresponding to the power rating , as determined from the following formula:

$$RCWV = VP \times R$$

Where:

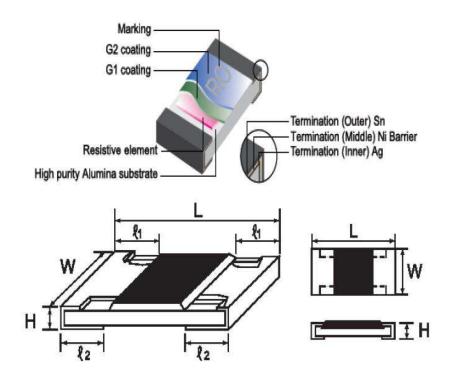
RCWV = Rated DC or RMS AC continuous working voltage at commercial-line frequency and waveform (volt)

P = Power Rating (watt)

R = Nominal Resistance (ohm)

In no case shall the rated DC or RMS AC continuous working voltage be greater than the applicable maximum value.

Construction & Dimensions:

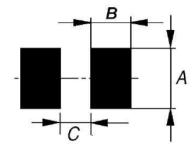


Dimensions: (mm)

L	W	Н	£ 1	€2
6.35±0.10	3.20±0.15	0.55±0.10	0.60±0.25	0.50±0.20



Recommended solder pad



A	В	C
3.7 mm.	2.8 mm.	2.7 mm.

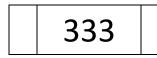
4 layers PCB specification:

- 1) Outside 2 layers (Top and Bottom) with copper foil thickness at 2oz.
- 2) Inside 2 layers (Middle layers) with copper foil thickness at 4 oz.

Marking:

For E24 series Values three digit marking, the first two digits are significant figures and the third denoting number of zeros.

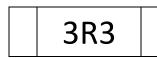
E.G.



 $33 \text{K}\Omega$

For Ohmic Values below 10Ω

E.G.



3.3Ω

For E96 Values four digit marking, the first three showing significant figures and the fourth showing number of zeros. As previously letter R is for decimal point.

E.G.

4992

49Κ9Ω



Performance Specification:

Operational life (MIL-STD-202)	125°C, at 35% of operating power, 1000H		
(MIL-S1D-202)	(1.5 hours "ON", 0.5 hour "OFF").		
<100mΩ Apply to rate current for 0Ω	, ,		
Parametrically test per lot and			
Electrical $1\Omega \le R \le 10\Omega \le \pm 400 PPM/^{\circ}C$ requirements, summary to sh			
Characterisation $10\Omega < R \le 100\Omega \le \pm 200PPM/^{\circ}C$ Mean and Standard deviation $100\Omega < R \le 100M\Omega \le \pm 100PPM/^{\circ}C$ well as Min and Max operating			
	ıg		
temperatures. (User Spec) Electrical test not required. Ir	sepact davica		
External Visual No Mechanical Damage construction, marking and wo	•		
(MIL-STD-883 Method 2009)	51Killuli3ilip		
Verify physical dimensions to	the applicable		
device detail specification			
Physical Reference 2.0 Dimension Note: User(s) and Suppliers si	pec. Electrical		
Dimension Standards test not required.	•		
(JESD22 MH Method JB-100))		
Note: Add Aqueous wash che	emical – OKEM		
Resistance to Clean or equivalent.			
Solvent Do not use banned solvents.			
(MIL-STD-202 Method 215)			
Terminal Strength Not broken Force of 1.8kg for 60 seconds	i .		
(JIS-C-6429)			
1000hrs. @T=155°C.Unpower			
High Temperature Resistance change rate is Measurement at 24±2 hours	after test		
Exposure $\pm (0.5\% + 0.1\Omega)$ Max. conclusion.			
(Storage) (MIL-STD-202 Method 108)			
<50mΩ Apply to rate current for 0Ω 1000 Cycles (-55°C to +155°C)	Moscuromont		
I Resistance change rate is	•		
Temperature $\pm (0.5\%+0.1\Omega)$ Max. at 24±2 hours after test concluding cycling (JESD22 Method JA-104)	iusion		
$<$ 50mΩ Apply to rate current for 0Ω			
Moisture Resistance change rate is $\pm (0.5\%+0.1\Omega)$ Max. The property of the contract of the			
Measurement at 24±2 hours	after test		
I conductor			
conclusion. (MIL-STD-202 Method 106)			
(MIL-STD-202 Method 106)	11 100011		
	KH. TUUUH:		
$ \begin{array}{c c} & \textbf{(MIL-STD-202 Method 106)} \\ \hline < 50 m\Omega & Apply to rate current for 0\Omega \\ \hline & 10\% \text{ rated power, } 85^{\circ}\text{C/85\%R} \\ \hline & Resistance change rate is \\ \hline & Biased Humidity & \pm (1\%+0.1\Omega) \text{ Max} \\ \hline & \textbf{(MIL-STD-202 Method 103)} \\ \hline \end{array} $	er test		
	er test		
$ \begin{array}{c c} & \textbf{(MIL-STD-202 Method 106)} \\ \hline < 50m\Omega & Apply to rate current for 0\Omega \\ \hline & 10\% \text{ rated power, } 85^{\circ}\text{C/85\%R} \\ & Resistance change rate is \\ & \pm (1\%+0.1\Omega) \text{ Max} & conclusion. \\ \hline & \textbf{(MIL-STD-202 Method 103)} \\ \hline < 100m\Omega & Apply to rate current for 0\Omega \\ \hline & Wave Form: Tolerance for ha \\ \hline \end{array} $	er test		
$ \begin{array}{c c} & \textbf{(MIL-STD-202\ Method\ 106)} \\ \hline < 50m\Omega & Apply\ to\ rate\ current\ for\ 0\Omega \\ \hline \\ & Resistance\ change\ rate\ is \\ & \pm (1\%+0.1\Omega)\ Max & Measurement\ at\ 24\ hours\ aft\ conclusion. \\ \hline & \textbf{(MIL-STD-202\ Method\ 103)} \\ \hline < 100m\Omega & Apply\ to\ rate\ current\ for\ 0\Omega \\ \hline \\ & Mechanical\ Shock & \pm (1\%+0.1\Omega)\ max & Uave\ Form:\ Tolerance\ for\ half pulse.\ Peak\ value\ is\ 100g's.\ N \\ \hline & \textbf{(D)}\ is\ 6. \\ \hline & \textbf{(MIL-STD-202\ Method\ 213)} \\ \hline \end{array} $	er test If sine shock ormal duration		
$ \begin{array}{c c} & \textbf{(MIL-STD-202\ Method\ 106)} \\ \hline < 50m\Omega & Apply\ to\ rate\ current\ for\ 0\Omega \\ \hline & 10\%\ rated\ power,\ 85^{\circ}C/85\%R \\ & Measurement\ at\ 24\ hours\ aft\ conclusion. \\ \hline & \textbf{(MIL-STD-202\ Method\ 103)} \\ \hline < 100m\Omega & Apply\ to\ rate\ current\ for\ 0\Omega \\ \hline & Wave\ Form:\ Tolerance\ for\ ha\ pulse.\ Peak\ value\ is\ 100g's.\ N\ (D)\ is\ 6. \\ \hline & \textbf{(MIL-STD-202\ Method\ 213)} \\ \hline & 5g's\ for\ 20\ min.\ 12\ cycle\ each \\ \hline \end{array} $	er test If sine shock ormal duration		
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$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	If sine shock ormal duration of 3 ick 7 secure 2 secure points		
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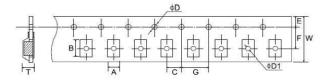


Performance Specification (continued)

Characteristics	Limits	Test Methods		
		-55°C/+155°C		
	±(1%+0.1Ω) max	Note: Number of cycles required -300,		
Thermal Shock		Maximum transfer time -20 seconds, Dwell		
Thermal Shock		time -15 minutes. Air-Air.		
		(MIL-STD-202 Method 107)		
	<50mΩ	Apply to rate current for 0Ω		
		With the electrometer in direct contact with		
		the discharge tip, verify the voltage setting		
		at levels of		
ESD	±(10%+0.1W)max	±500V,±1KV, ±2KV, ±4KV, ±8KV,		
		The electrometer reading shall be within		
		±10% for voltages from 500V to ≦800V.		
		(AEC-Q200-002)		
		For both leaded & SMD. Electrical test not		
		required		
		Magnification 50X. Conditions:		
Solderability	95% coverage Min.	a) Method B 4hrs at 155°C dry heat, the di		
Solderability		in bath with 245°C,5s.		
		b) Method B: at 215°C,5s.		
		c) Method D: at 260°C, 60s.		
		(J-STD-002)		
	No ignition of the tissue paper or	V-0 or V-1 are acceptable. Electrical test not		
Flammability	scorching of the pinewood board	required.		
	scorening of the pinewood board	(UL-94)		
Board Flex	±(1%+0.05W)max	2mm (Min) (JIS-C-6429)		
Board Flex	<50mW	Apply to rate current for 0 W		
		Temperature sensing at 5002, Voltage		
		power subjected to 32VDC current clamped		
Flame Retardance	No flame	up to 500ADC and decreased in		
		1.0VDC/hour.		
		(AEC-Q200-001)		
		Condition B No per-heat of samples. Note:		
		Single Wave Solder-Procedure 2 for SMD		
Resistance to	±(1%+0.05Ω)max.	and Procedure 1 for Leaded with solder		
soldering Heat		within 1.5mm of device body.		
		(MIL-STD-202 Method 210)		
	<50mW	Apply to rate current for 0 W		
* Sulfuration test: H	12S 3~5PPM 502±22 91%~93%RH 10	000H		

Packaging specification

Embossed Taping:

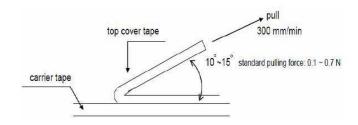


Α	В	С	ØD+0.1	ØD1+0.1	E	F	G	W	Τ±
±0.2	±0.2	±0.05	-0	-0	±0.1	±0.05	±0.1	±0.2	0.1
3.50	6.70	2.0	1.5	1.5	1.75	5.5	4.0	12.0	1.0

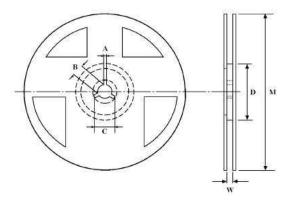


Peeling Strength of Top Cover Tape

Test Condition: 0.1 to 0.7 N at a peel-off speed of 300 mm / min.



Reel Dimensions



Tape	Reel	A ±	В±	C ±	D ± 1	M ± 2	W ± 1
	Qty	0.5	0.5	0.5			
Embossed	4,000	2	13	21	60	178	13.8

Environment Related Substance

This product complies to EU RoHS directive, EU PAHs directive, EU PFOS directive and Halogen free.

Ozone layer depleting substances.

Ozone depleting substances are not used in our manufacturing process of this product.

This product is not manufactured using Chloro fluorocarbons (CFCs), Hydrochlorofluorocarbons (HCFCs), Hydrobromofluorocarbons (HBFCs) or other ozone depleting substances in any phase of the manufacturing process.



Storage Condition

The performance of these products, including the solderability, is guaranteed for a year from the date of arrival at your company, provided that they remain packed as they were when delivered and stored at a temperature of $25^{\circ}\text{C} \pm 10^{\circ}\text{C}$ and a relative humidity of 60%RH \pm 10%RH, chemical and dust free atmosphere

Even within the above guarantee periods, do not store these products in the following conditions, otherwise their electrical performance and/or solderability may be deteriorated, and the packaging materials (e.g. taping materials) may be deformed or deteriorated, resulting in mounting failures.

- 1. In salty air or in air with a high concentration of corrosive gas, such as Cl2, H2S, NH3, SO2, or NO2
- 2. In direct sunlight

AEC-Q200

The 3521 series is qualified to AEC-Q200 standard at Grade"4"

How To Order

3521	10K	F	
Common Part	Resistance Value	Tolerance	Pack Style
3521 – SMD Power Resistor	1Ω - 1R0 100Ω - 100R 1,000Ω (1ΚΩ) -1Κ0 10,000Ω (10ΚΩ) - 10Κ 1,000,000Ω (1ΜΩ) - 1Μ0	F – 1%	T – 4000 Reel